Applicant(s)/Patent Under Reexamination Application/Control No. 10/707,803 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Linh V. Nguyen 2819 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,034,308	07-1977	Wermuth et al.	330/86
*	В	US-6,617,838	09-2003	Miranda et al.	324/117R
*	С	US-6,249,240	06-2001	Bellaouar, Abdellatif	341/172
*	D	US-5,856,758	01-1999	Joffe et al.	330/85
*	E	US-5,220,286	06-1993	Nadeem, Shujaat	330/9
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	v					
	w					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.